











TLC5925

SLVS765B - OCTOBER 2008-REVISED SEPTEMBER 2015

TLC5925 Low-Power 16-Channel Constant-Current LED Sink Driver

Features

- 16 Constant-Current Output Channels
- Constant Output Current Invariant to Load Voltage Change
- **Excellent Output Current Accuracy:**
 - Between Channels: < ±4% (Max)
 - Between ICs: < ±6% (Max)
- Constant Output Current Range: 3 mA to 45 mA
- Output Current Adjusted By External Resistor
- Fast Response of Output Current, OE (Min):
- 30-MHz Clock Frequency
- Schmitt-Trigger Inputs
- 3.3-V to 5-V Supply Voltage
- Thermal Shutdown for Overtemperature Protection
- ESD Performance: 1-kV HBM

Applications

- Gaming Machine and Entertainment
- General LED Applications
- LED Display Systems
- Signs LED Lighting
- White Goods

3 Description

The TLC5925 is designed for LED displays and LED lighting applications. The TLC5925 contains a 16-bit shift register and data latches, which convert serial input data into parallel output format. At the TLC5925 output stage, 16 regulated-current ports provide uniform and constant current for driving LEDs within a wide range of VF variations. Used in system design for LED display applications (such as, LED panels), the TLC5925 provides great flexibility and device performance. Users can adjust the output current from 3 mA to 45 mA through an external resistor, Rext, which gives flexibility in controlling the light intensity of LEDs. TLC5925 is designed for up to 17 V at the output port. The high clock frequency, 30 MHz, also satisfies the system requirements of highvolume data transmission.

The serial data is transferred into TLC5925 via SDI, shifted in the shift register, and transferred out via SDO. LE can latch the serial data in the shift register to the output latch. OE enables the output drivers to sink current.

Device Information (1)

PART NUMBER	PACKAGE	BODY SIZE (NOM)					
	SSOP (24)	8.65 mm × 3.90 mm					
TLC5925	SOIC (24)	15.40 mm × 7.50 mm					
	TSSOP (24)	7.80 mm × 4.40 mm					

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Typical Application

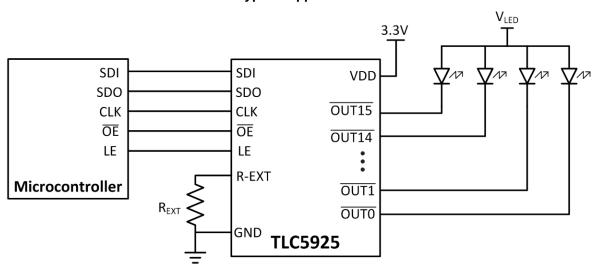




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

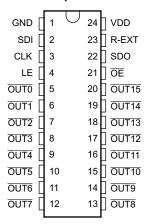
Changes from Revision A (March 2013) to Revision B

Page



5 Pin Configuration and Functions

DBQ, DW, or PWP Package 24-Pin SSOP, SOIC, or TSSOP Top View



Pin Functions

PIN		1/0	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
CLK	3	I	Clock input for data shift on rising edge
GND	1	_	Ground for control logic and current sink
LE	4	I	Data strobe input Serial data is transferred to the respective latch when LE is high. The data is latched when LE goes low. LE has an internal pull-down resistor.
ŌĒ	21	I	Output enable When \overline{OE} is active (low), the output drivers are enabled. When \overline{OE} is high, all output drivers are turned OFF (blanked). \overline{OE} has an internal pullup resistor.
OUT0	5		
OUT1	6		
OUT2	7		
OUT3	8		
OUT4	9		
OUT5	10		
OUT6	11		
OUT7	12	0	Constant-current outputs
OUT8	13		Constant-current outputs
OUT9	14		
OUT10	15		
OUT11	16		
OUT12	17		
OUT13	18		
OUT14	19		
OUT15	20		
R-EXT	23	I	Input used to connect an external resistor (R _{ext}) for setting output currents
SDI	2	I	Serial-data input to the Shift register
SDO	22	0	Serial-data output to the following SDI of next driver IC or to the microcontroller
VDD	24	I	Supply voltage



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
V_{DD}	Supply voltage	0	7	V
V_{I}	Input voltage	-0.4	$V_{DD} + 0.4$	V
Vo	Output voltage	-0.5	20	V
I _{OUT}	Output current		45	mA
I_{GND}	GND terminal current		750	mA
T_A	Free-air operating temperature range	-40	125	°C
T_{J}	Operating junction temperature range	-40	150	°C
T _{stg}	Storage temperature range	-55	150	°C

⁽¹⁾ Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
.,	Flootroptotic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±1000	\/
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)	±500	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

				MIN	MAX	UNIT
V_{DD}	Supply voltage			3	5.5	V
Vo	Output voltage	OUT0 to OUT15			17	V
I _O	Output current	DC test circuit	V _O ≥ 0.6 V	3		A
		DC test circuit	V _O ≥ 1 V		45	mA
I _{OH}	High-level output current	SDO		-1		mA
I _{OL}	Low-level output current	SDO		1		mA
V_{IH}	High-level input voltage	CLK, OE, LE, and SDI		$0.7 \times V_{DD}$	V_{DD}	V
V_{IL}	Low-level input voltage	CLK, OE, LE, and SDI		GND	$0.3 \times V_{DD}$	V
t_R	Rise Time	CLK			500	ns
t _F	Fall Time	CLK			500	ns

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.4 Thermal Information

				TLC5925		
	THERMAL METRIC (1)		DBQ (SSOP)	DW (SOIC)	PW (TSSOP)	UNIT
				24 PINS	24 PINS	
	Junction-to- ambient thermal resistance	Mounted on JEDEC 1-layer board (JESD 51-3), No airflow	99.8	80.5	118.8	°C/W
$R_{\theta JA}$		Mounted on JEDEC 4-layer board (JESD 51-7), No airflow	61	45.5	87.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (to	p) thermal resistance	52.9	45.0	44.9	°C/W
$R_{\theta JB}$	Junction-to-board th	ermal resistance	41.5	44.8	52.9	°C/W
Ψ_{JT}	Junction-to-top char	acterization parameter	16.4	21.7	6.7	°C/W
Ψ_{JB}	Junction-to-board characterization parameter		41.2	44.4	52.5	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bo	ottom) thermal resistance	n/a	n/a	n/a	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.5 Electrical Characteristics: $V_{DD} = 3 \text{ V}$

 V_{DD} = 3 V, T_J = -40°C to 125°C (unless otherwise noted)

	PARAMETER	TEST (CONDITIONS	MIN	TYP	MAX	UNIT
V _{DD}	Input voltage			3		5.5	V
Vo	Output voltage					17	V
	Outside summer!	V _O ≥ 0.6 V		3			^
lo	Output current	V _O ≥ 1 V	V _O ≥ 1 V			45	mA
I _{OH}	High-level output current, source			-1			^
I _{OL}	Low-level output current, sink						mA
V _{IH}	High-level input voltage			$0.7 \times V_{DD}$		V_{DD}	.,
V _{IL}	Low-level input voltage			GND		$0.3 \times V_{DD}$	V
	0	.,	$T_J = 25^{\circ}C$			0.5	
l _{leak}	Output leakage current	V _{OH} = 17 V	$T_{\rm J} = 17 \rm V$ $T_{\rm J} = 125 \rm ^{\circ} C$			2	μΑ
V _{OH}	High-level output voltage	SDO, $I_{OL} = -1 \text{ mA}$		$V_{DD} - 0.4$			V
V _{OL}	Low-level output voltage	SDO, I _{OH} = 1 mA				0.4	V
	Output current 1	$V_{OUT} = 0.6 \text{ V}, R_{ext} =$		13		mA	
I _{O(1)}	Output current error, die-die	$I_{OL} = 13 \text{ mA}, V_{O} = 0.0$ $T_{J} = 25^{\circ}\text{C}$		±3%	±6%		
,	Output current error, channel-to- channel	$I_{OL} = 13 \text{ mA}, V_O = 0.0$ $T_J = 25^{\circ}\text{C}$		±1.5%	±4%		
	Output current 2	$V_0 = 0.8 \text{ V}, R_{ext} = 84$	-0 Ω		26		mA
I _{O(2)}	Output current error, die-die	$I_{OL} = 26 \text{ mA}, V_O = 0.5$ $T_J = 25^{\circ}\text{C}$	8 V, $R_{ext} = 840 \Omega$,		±3%	±6%	
	Output current error, channel-to- channel	$I_{OL} = 26 \text{ mA}, V_O = 0.5$ $T_J = 25^{\circ}\text{C}$	8 V, $R_{ext} = 840 \Omega$,		±1.5%	±4%	
I _{OUT} vs	Output current vs	$V_{O} = 1 \text{ V to 3 V, I}_{O} =$	= 13 mA		±0.1		0/ 0/
V _{OUT}	output voltage regulation	$V_{DD} = 3.0 \text{ V to } 5.5 \text{ V},$	I _O = 13 mA to 45 mA		±1		%/V
	Pullup resistance	ŌE			500		kΩ
	Pulldown resistance	LE			500		kΩ
T _{sd}	Overtemperature shutdown (1)			150	175	200	°C
T _{hys}	Restart temperature hysteresis				15		°C
·		R _{ext} = Open			7	10	
I_{DD}	Supply current	R _{ext} = 1680 Ω			9	12	mA
		$R_{\text{ext}} = 840 \ \Omega$			11	13	•
C _{IN}	Input capacitance	$V_I = V_{DD}$ or GND, CL	K, SDI, SDO, OE			10	pF

Product Folder Links: TLC5925

(1) Specified by design



6.6 Electrical Characteristics: $V_{DD} = 5.5 \text{ V}$

 $V_{DD} = 5.5 \text{ V}, T_{J} = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$

	PARAMETER	TEST (CONDITIONS	MIN	TYP	MAX	UNIT
V _{DD}	Input voltage			3		5.5	V
Vo	Output voltage					17	V
	Output summent	V _O ≥ 0.6 V		3			A
lo	Output current	V _O ≥ 1 V				45	mA
I _{OH}	High-level output current, source						A
I _{OL}	Low-level output current, sink			1			mA
V _{IH}	High-level input voltage			$0.7 \times V_{DD}$		V_{DD}	V
V _{IL}	Low-level input voltage			GND		03 × V _{DD}	V
	Output lookage ourrent	V _{OH} = 17 V	$T_J = 25^{\circ}C$			0.5	
l _{leak}	Output leakage current	V _{OH} = 17 V	T _J = 125°C			2	μA
V_{OH}	High-level output voltage	SDO, $I_{OL} = -1 \text{ mA}$		$V_{DD} - 0.4$			V
V_{OL}	Low-level output voltage	SDO, I _{OH} = 1 mA				0.4	V
	Output current 1	V _{OUT} = 0.6 V, R _{ext} =		13		mA	
I _{O(1)}	Output current error, die-die	$I_{OL} = 13 \text{ mA}, V_O = 0.0$ $T_J = 25^{\circ}\text{C}$		±3\$	±6\$		
	Output current error, channel-to- channel	$I_{OL} = 13 \text{ mA}, V_{O} = 0.0$ $T_{J} = 25^{\circ}\text{C}$		±1.5\$	±4\$		
	Output current 2	$V_0 = 0.8 \text{ V}, R_{\text{ext}} = 84$	0 Ω		26		mA
I _{O(2)}	Output current error, die-die	$I_{OL} = 26 \text{ mA}, V_O = 0.8$ $T_J = 25^{\circ}\text{C}$	$I_{OL} = 26 \text{ mA}, V_O = 0.8 \text{ V}, R_{ext} = 840 \Omega,$			±6%	
	Output current error, channel-to- channel	$I_{OL} = 26 \text{ mA}, V_O = 0.8$ $T_J = 25^{\circ}\text{C}$	8 V, R _{ext} = 840 Ω,		±1.5%	±4%	
I _{OUT} vs	Output current vs	$V_O = 1 \text{ V to } 3 \text{ V}$, $I_O =$	= 26 mA		±0.1		0/ 0/
V _{OUT}	output voltage regulation	$V_{DD} = 3.0 \text{ V to } 5.5 \text{ V},$	I _O = 13 mA to 45 mA		±1		%/V
	Pullup resistance	ŌĒ			500		kΩ
	Pulldown resistance	LE			500		kΩ
T _{sd}	Overtemperature shutdown (1)			150	175	200	°C
T _{hys}	Restart temperature hysteresis				15		°C
·		R _{ext} = Open			9	11	
I_{DD}	Supply current	R _{ext} = 1680 Ω			12	14	mA
		R _{ext} = 840 Ω			14	16	
C _{IN}	Input capacitance	$V_I = V_{DD}$ or GND, CL	K, SDI, SDO, OE			10	pF

⁽¹⁾ Specified by design

6.7 Power Dissipation and Thermal Impedance

		MIN MAX	UNIT		
P_D		Mounted on JEDEC 4-layer board (JESD 51-7), No airflow, $T_A = 25^{\circ}C$, $T_J = 125^{\circ}C$	DBQ package	1.6	1
	Power dissipation		DW package	2.2	W
			PW package	1.1	i



6.8 Timing Requirements

 $V_{DD} = 3 \text{ V to } 5.5 \text{ V (unless otherwise noted)}$

		MIN	MAX	UNIT
t _{w(L)}	LE pulse duration	15		ns
t _{w(CLK)}	CLK pulse duration	15		ns
t _{w(OE)}	OE pulse duration	300		ns
t _{su(D)}	Setup time for SDI	3		ns
t _{h(D)}	Hold time for SDI	2		ns
t _{su(L)}	Setup time for LE	5		ns
t _{h(L)}	Hold time for LE	5		ns
f _{CLK}	Clock frequency, Cascade operation		30	MHz

6.9 Switching Characteristics: $V_{DD} = 3 \text{ V}$

 $V_{DD} = 3 \text{ V}, T_{J} = -40 ^{\circ}\text{C} \text{ to } 125 ^{\circ}\text{C} \text{ (unless otherwise noted)}$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH1}	Low-to-high propagation delay time, CLK to OUTn		30	45	60	ns
t _{PLH2}	Low-to-high propagation delay time, LE to OUTn		30	45	60	ns
t _{PLH3}	Low-to-high propagation delay time, OE to OUTn		30	45	60	ns
t _{PLH4}	Low-to-high propagation delay time, CLK to SDO			30	40	ns
t _{PHL1}	High-to-low propagation delay time, CLK to OUTn		40	65	100	ns
t _{PHL2}	High-to-low propagation delay time, LE to OUTn		40	65	100	ns
t _{PHL3}	High-to-low propagation delay time, OE to OUTn		40	65	100	ns
t _{PHL4}	High-to-low propagation delay time, CLK to SDO			30	40	ns
t _{w(CLK)}	Pulse duration, CLK	$V_{IH} = V_{DD}, V_{IL} = GND,$	15			ns
t _{w(L)}	Pulse duration LE	$R_{ext} = 840 \Omega, V_{L} = 4 V,$	15			ns
t _{w(OE)}	Pulse duration, OE	$R_L = 88 \Omega, C_L = 10 pF$	300			ns
t _{h(D)}	Hold time, SDI		2			ns
t _{su(D)}	Setup time, SDI		3			ns
t _{h(L)}	Hold time, LE		5			ns
t _{su(L)}	Setup time, LE		5			ns
t _r	Rise time, CLK ⁽¹⁾				500	ns
t _f	Fall time, CLK (1)				500	ns
t _{or}	Rise time, outputs (off)		35	50	70	ns
t _{of}	Rise time, outputs (on)		15	50	120	ns
f _{CLK}	Clock frequency	Cascade operation			30	MHz

⁽¹⁾ If the devices are connected in cascade and t_r or t_f is large, it may be critical to achieve the timing required for data transfer between two cascaded devices.



6.10 Switching Characteristics: $V_{DD} = 5.5 \text{ V}$

 $V_{DD} = 5.5 \text{ V}, T_J = -40^{\circ}\text{C} \text{ to } 125^{\circ}\text{C} \text{ (unless otherwise noted)}$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH1}	Low-to-high propagation delay time, CLK to OUTn		20	35	55	ns
t _{PLH2}	Low-to-high propagation delay time, LE to OUTn		20	35	55	ns
t _{PLH3}	Low-to-high propagation delay time, $\overline{\text{OE}}$ to $\overline{\text{OUTn}}$		20	35	55	ns
t _{PLH4}	Low-to-high propagation delay time, CLK to SDO			20	30	ns
t _{PHL1}	High-to-low propagation delay time, CLK to OUTn		15	28	42	ns
t _{PHL2}	High-to-low propagation delay time, LE to OUTn		15	28	42	ns
t _{PHL3}	High-to-low propagation delay time, $\overline{\text{OE}}$ to $\overline{\text{OUTn}}$		15	28	42	ns
t _{PHL4}	High-to-low propagation delay time, CLK to SDO			20	30	ns
t _{w(CLK)}	Pulse duration, CLK	$V_{IH} = V_{DD}, V_{IL} = GND,$	10			ns
t _{w(L)}	Pulse duration LE	$R_{ext} = 840 \Omega, V_1 = 4 V,$	10			ns
t _{w(OE)}	Pulse duration, OE	$R_L = 88 \Omega, C_L = 10 pF$	200			ns
t _{h(D)}	Hold time, SDI		2			ns
t _{su(D)}	Setup time, SDI		3			ns
t _{h(L)}	Hold time, LE		5			ns
t _{su(L)}	Setup time, LE		5			ns
t _r	Rise time, CLK ⁽¹⁾				500	ns
t _f	Fall time, CLK ⁽¹⁾				500	ns
t _{or}	Rise time, outputs (off)		25	45	65	ns
t _{of}	Rise time, outputs (on)		7	12	20	ns
f _{CLK}	Clock frequency	Cascade operation			30	MHz

⁽¹⁾ If the devices are connected in cascade and t_r or t_f is large, it may be critical to achieve the timing required for data transfer between two cascaded devices.



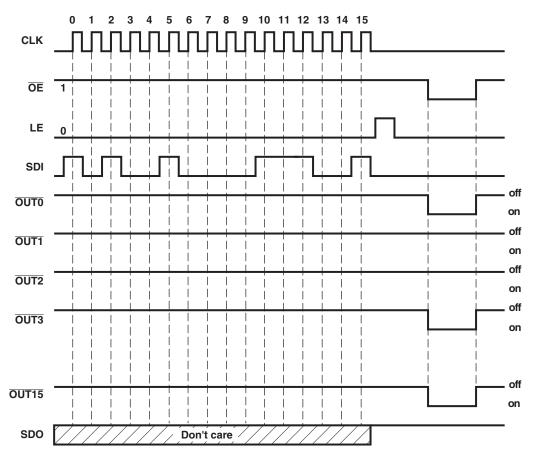


Figure 1. Timing Diagram

6.11 Typical Characteristics

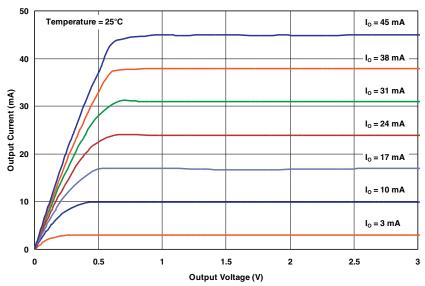


Figure 2. Output Current vs Output Voltage

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7 Parameter Measurement Information

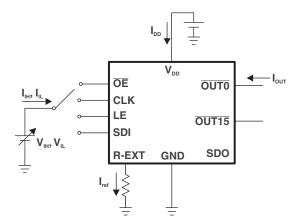


Figure 3. Test Circuit for Electrical Characteristics

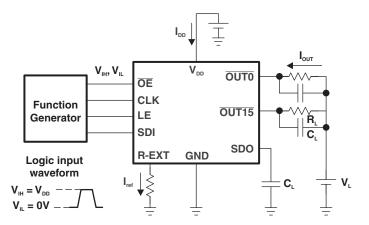


Figure 4. Test Circuit for Switching Characteristics

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Parameter Measurement Information (continued)

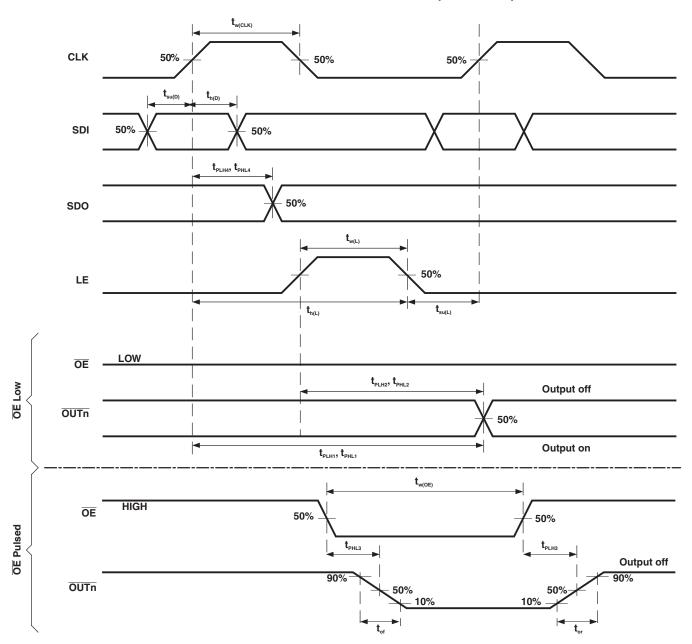


Figure 5. Normal Mode Timing Waveforms

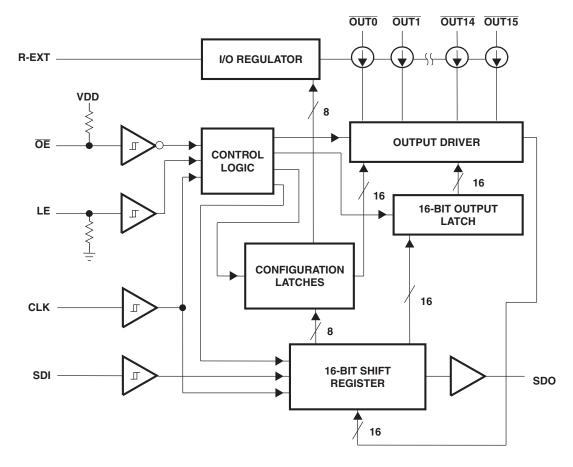


8 Detailed Description

8.1 Overview

The TLC5925 is a 16-channel LED driver designed for LED displays and LED lighting applications. The TLC5925 contains a 16-bit shift register and data latches, which convert serial input data into parallel output format. At the TLC5925 output stage, 16 regulated-current ports provide uniform and constant current for driving LEDs within a wide range of VF variations. Used in system design for LED display applications (for example, LED panels), the TLC5925 provides great flexibility and device performance. Users can adjust the output current from 3 mA to 45 mA through an external resistor, REXT, which gives flexibility in controlling the light intensity of LEDs. TLC59025 is designed for up to 17 V at the output port. The high clock frequency, 30 MHz, also satisfies the system requirements of high-volume data transmission.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Constant Current

In LED display applications, TLC5925 provides nearly no current variations from channel to channel and from IC to IC. While $I_{OUT} \le 45$ mA, the maximum current skew between channels is less than $\pm 5\%$ and between ICs is less than $\pm 6\%$.



8.4 Device Functional Modes

The table below lists the functional modes for the TLC5925.

Table 1. Truth Table in Normal Operation

CLK	LE	ŌĒ	SDI	OUT0OUT15OUT15	SDO
↑	Н	L	Dn	DnDn – 7Dn – 15	Dn – 15
↑	L	L	Dn + 1	No change	Dn – 14
1	Н	L	Dn + 2	Dn + 2Dn – 5Dn – 13	Dn – 13
	X	L	Dn + 3	Dn + 2Dn – 5Dn – 13	Dn – 13
↓	X	Н	Dn + 3	off	Dn – 13



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

9.1.1 Turning on the LEDs

To turn on an LED connected to one of the outputs of the device, the output must be pulled low. To do this, the SDI signal must let the device know which outputs should be activated. Using the rising edge of CLK, the logic level of the SDI signal latches the desired state of each output into the shift register. Once this is complete, the LE signal must be toggled from low to high then back to low. Once /OE is pulled down, the corresponding outputs will be pulled low and the LEDs will be turned on. The below diagram shows outputs 0, 3, 4, 5, 10, 13, and 15 being activated.

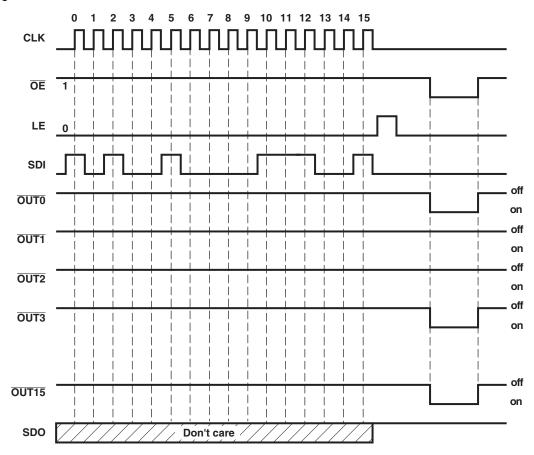


Figure 6. Timing Diagram



Application Information (continued)

9.1.2 Propagation Delay Times

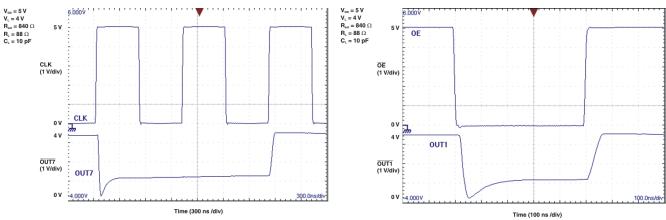


Figure 7. CLK to OUT7

Figure 8. OE to OUT1

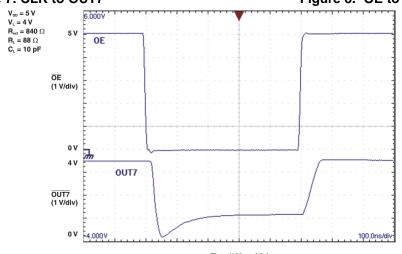
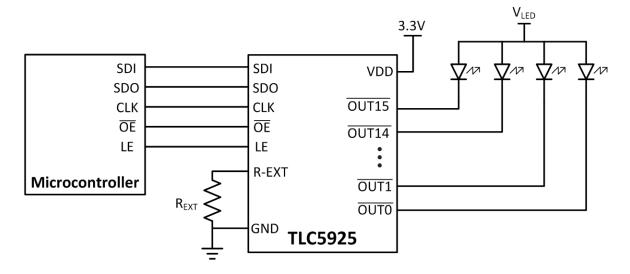


Figure 9. OE to OUT7

9.2 Typical Application





Typical Application (continued)

9.2.1 Design Requirements

For the following design procedure, the input voltage (VDD) is between 3 V and 5.5 V.

9.2.2 Detailed Design Procedure

9.2.2.1 Adjusting Output Current

TLC5925 sets I_{OUT} based on the external resistor R_{ext} . Users can follow the below formulas to calculate the target output current $I_{OUT,target}$ in the saturation region:

 $I_{OUT,target} = (1.21 \text{ V} / R_{ext}) \times 18$, where R_{ext} is the external resistance connected between R-EXT and GND.

Therefore, the default current is approximately 26 mA at 840 Ω and 13 mA at 1680 Ω .

9.2.3 Application Curve

The default relationship after power on between I_{OUT,target} and R_{ext} is shown in Figure 10.

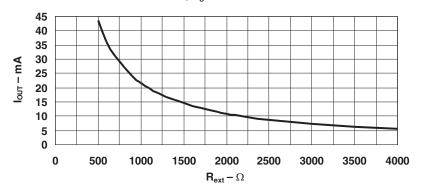


Figure 10. Default Relationship Curve Between I_{OUT,target} and R_{ext} After Power Up

10 Power Supply Recommendations

The TLC5925 is designed to operate with a VDD range between 3 V and 5.5 V.

11 Layout

11.1 Layout Guidelines

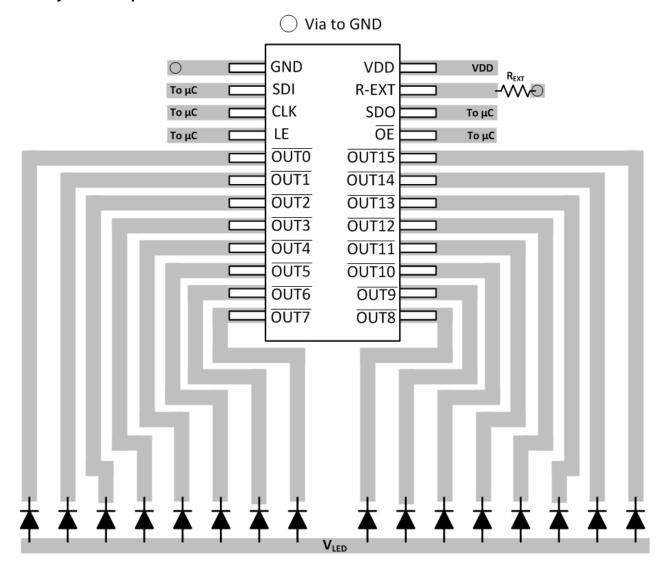
The SDI, CLK, SDO, LE, and OE signals should all be kept from potential noise sources.

All traces carrying power through the LEDs should be wide enough to handle necessary currents.

All LED current passes through the device and into the ground node. There must be a strong connection between the device ground and the circuit board ground.



11.2 Layout Example



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12 Device and Documentation Support

12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

10-Nov-2025

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/ Ball material	.		Part marking
	(1)	(2)			(3)	(4)	(5)		(6)
TLC5925IDBQR	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLC5925I
TLC5925IDBQR.B	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLC5925I
TLC5925IDBQRG4	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLC5925I
TLC5925IDBQRG4.B	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	TLC5925I
TLC5925IDWR	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TLC5925I
TLC5925IDWR.B	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TLC5925I
TLC5925IDWRG4	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TLC5925I
TLC5925IPWR	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	Y5925
TLC5925IPWR.B	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	Y5925
TLC5925IPWRG4	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	Y5925

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PACKAGE OPTION ADDENDUM

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and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

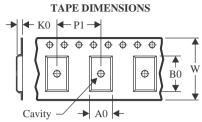
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC5925IDBQR	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC5925IDBQRG4	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC5925IDWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
TLC5925IPWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1



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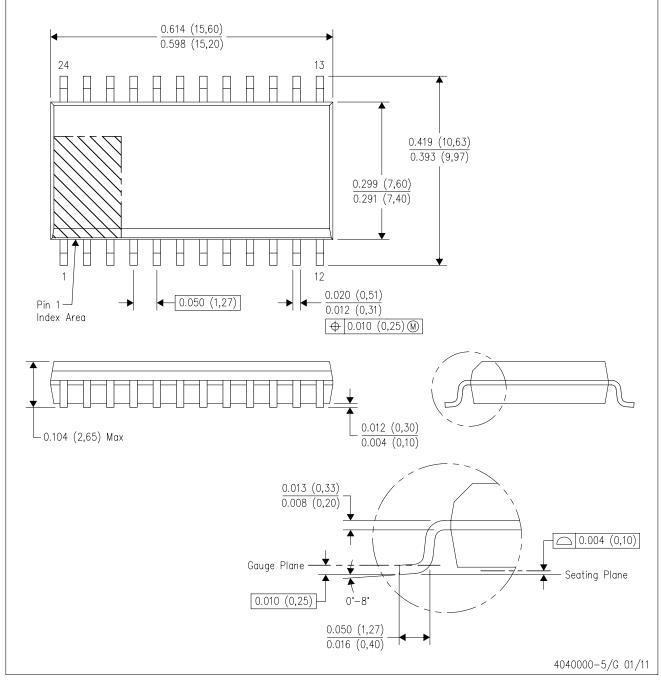


*All dimensions are nominal

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Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
TLC5925IDBQR	SSOP	DBQ	24	2500	353.0	353.0	32.0	
TLC5925IDBQRG4	SSOP	DBQ	24	2500	353.0	353.0	32.0	
TLC5925IDWR	SOIC	DW	24	2000	350.0	350.0	43.0	
TLC5925IPWR	TSSOP	PW	24	2000	353.0	353.0	32.0	

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



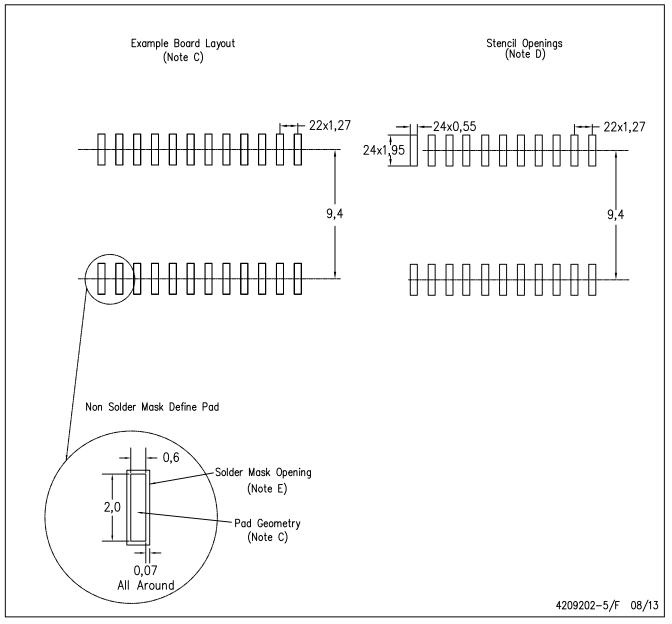
NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



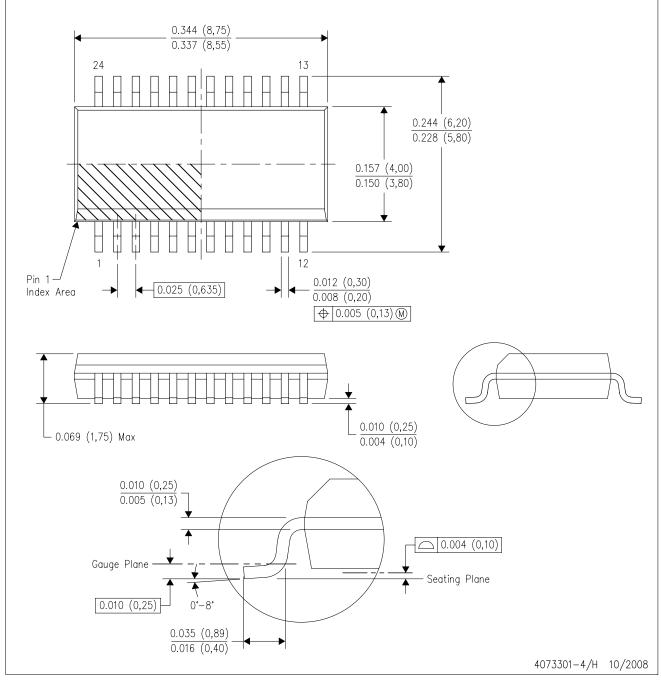
NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



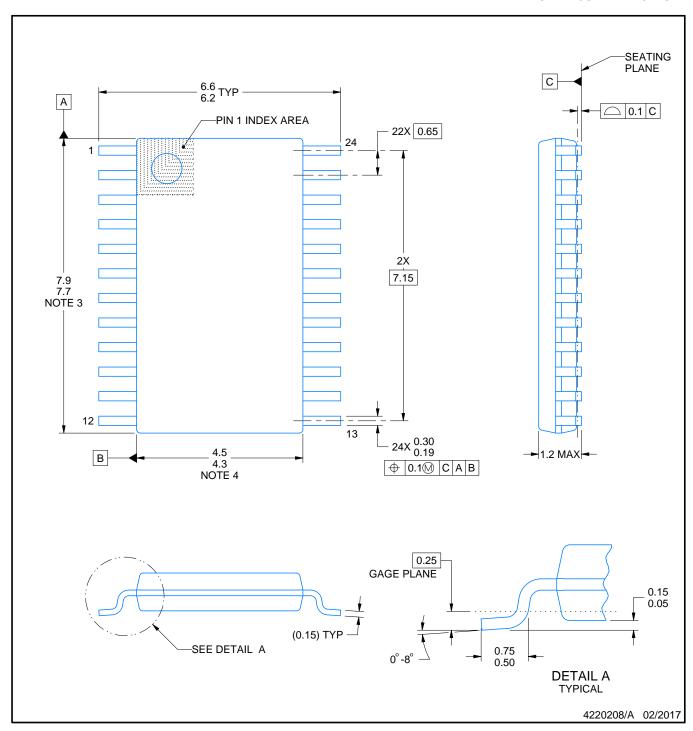
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.





SMALL OUTLINE PACKAGE



NOTES:

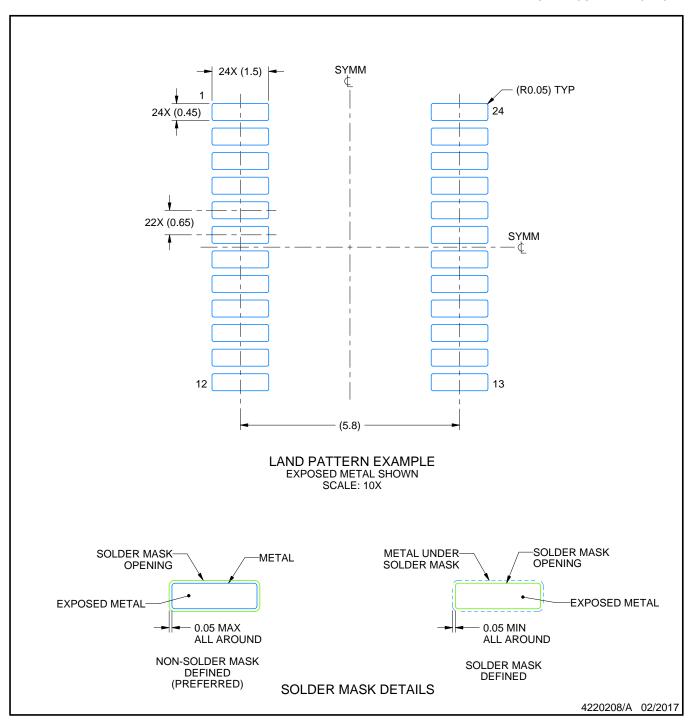
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



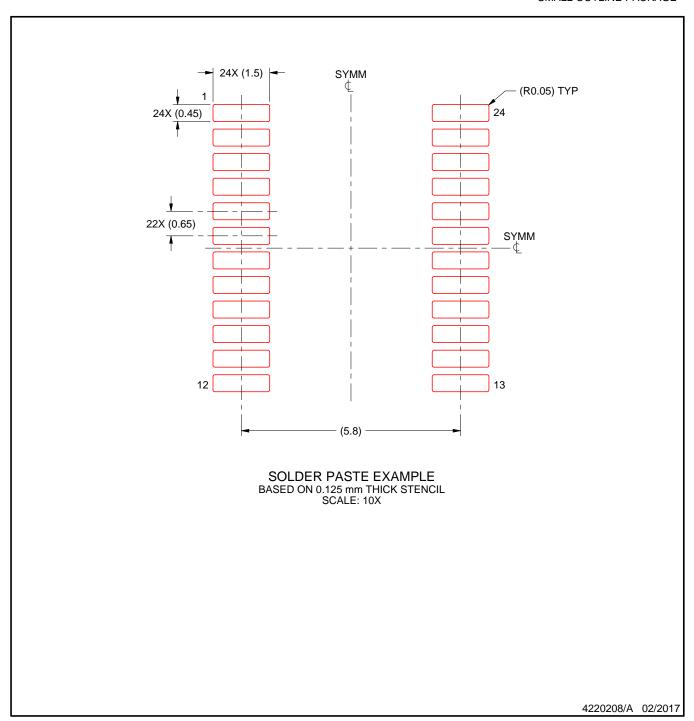
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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